

**Search Notes**

Application/Control No.

10/816,568

Examiner

Phuong Huynh

Applicant(s)/Patent under  
Reexamination

MAKEIG ET AL.

Art Unit

2857

**SEARCHED**

Class	Subclass	Date	Examiner
702	75	7/27/2005	PH
Updated	Above	3/8/2006	PH
702	76-77	3/8/2006	PH
702	189-191	3/8/2006	PH
702	194	3/8/2006	PH
Updated	Above	5/17/2006	PH
702	66-74	5/17/2006	PH
324	536	5/17/2006	PH
324	76.19	5/17/2006	PH

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
702	75	5/17/2006	PH

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Consulted with Primary Examiner Michael Nghiem	3/8/2006	PH
702/75-77 with text (see East for details)	3/8/2006	PH
702/189-191, 194 with text (see East for details)	3/8/2006	PH
Consulted with Primary Examiner Hal Wachsman	3/8/2006	PH
Combined citation, lists, inventor search and text	3/8/2006	PH
Consulted with Primary Examiner Michael Nghiem	5/17/2006	PH
Consulted with Primary Examiner Vincent Q. Nguyen: Search and Cross 324/76.19	5/17/2006	PH
(702/66-77, 189-191, 194) and (324/76.19,536) with text: see East	5/17/2006	PH

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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

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